

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10593637	DELMAS ET AL.
	Examiner	Art Unit
	RYAN LEPISTO	2883

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
See search history - EAST (all databases), non-patent literature (IEEE, OpticsInfoBase)	2/11/08	RAL

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner